DOCKET NO. ACBI.048.01US

## **PATENT**

## COMMISSIONER OF PATENTS AND TRADEMARKS Washington, D.C. 20231

## FORM PTO-1449 (Modified) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE SATEMENT (Use several sheets if necessary)

Sheet 1 of 1

In re the application of: Hung Pin Kao, et al.. Art Unit: 1746 Examiner: Not Yet Assigned Serial No. 09/660,992 Filed: August 13, 2000

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Ref.	Examiner's	Patent			Class/	<b>Filing</b>	
Desig.	<u>Initials</u>	<u>Number</u>	<u>Date</u>	<u>Name</u>	<u>Subclass</u>	<u>Date</u>	
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Chang and Hicks, "Mesa structure formation using potassium hydroxide and thylene diamine based etchants." IEEE Workshop on solid State Sensors and Actuators, pp. 102-

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Date Considered: 2

EXAMINER: Initial if citation considered, whether or not the citation conforms with MPEP 609. Draw a line through the citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.

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	<b>.</b>			Application Number	0,992				
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Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume issue number(s), publisher, city and/or country where published.							
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*EXAMINER: Initial if reference considered, whether or not criteria is in confor	mance with MPEP 609. Draw line through citation if not in conformance and not
considered. Include copy of this form with next communication	to application(s)